

2^{nd} generation thinQ!TM SiC Schottky Diode

Features:

Applications:

SMPS, PFC, snubber

The second secon

- Revolutionary Semiconductor Material -Silicon Carbide
- Switching Behaviour Benchmark
- No Reverse Recovery / No Forward Recovery
- Temperature Independent Switching Behaviour
- Qualified According to JEDEC¹⁾ Based on Target Applications

Chip Type	V_{R}	<i>I</i> _{Fn}	Die Size	Package
IDC04S60CE	600V	4A	1.146 x 0.968 mm ²	sawn on foil

Mechanical Parameter	s			
Die size		1.146x 0.968		
Area total		1.11		
Anode pad size		0.909 x 0.731		
Thickness		355	μm	
Wafer size		100	mm	
Max. possible chips per	wafer	6190		
Passivation frontside		Photoimide		
Pad metal		3200 nm AlSiCu		
Backside metal		Ni Ag -system		
Die bond		Electrically conductive epoxy glue and soft solder		
Wire bond		AI, ≤500μm		
Reject ink dot size		Ø 0.65mm; max 1.2mm		
	for original and sealed MBB bags	Ambient atmosphere air, Temperature 17°C – s < 6 month		
Storage environment ¹⁾	for open MBB bags	Acc. to IEC60721-3-3: Atmosphere >99% Nitrogen or ineligas, Humidity <25%RH, Temperature 17°C – 25°C, < 6 mo		

¹⁾ Designed for storage conditions according to Infineon TR14 (Application Note "Storage of Products Supplied by Infineon Technologies)

Designed for climate condition under operation according to IEC60721-3-3, class 3K3

Edited by INFINEON Technologies, IFAG IPC TD VLS, L4704E, Edition 1.2, 05.09.2012



Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	V_{RRM}	T _{vj} =25 °C	600	V
DC blocking voltage	V _{DC}		600	7 V
Continuous forward current, limited by T_{vjmax}	I _F	T _{vj} < 150°C	4	
Surge non repetitive forward current, sine halfwave	I _{F,SM}	$T_{\rm C}$ =25°C, $t_{\rm P}$ =10 ms $T_{\rm C}$ =150°C, $t_{\rm P}$ =10 ms	32	A
Repetitive peak forward current, limited by thermal resistance R_{th}	I _{F,RM}	$T_{\rm C} = 100^{\circ}{\rm C}, T_{\rm vj} = 150^{\circ}{\rm C},$ D=0.1	18	
Non-repetitive peak forward current	I _{F,max}	$T_{\rm C} = 25^{\circ}{\rm C}, \ t_{\rm P} = 10 \mu{\rm s}$	132	
i ² t value	$\int i^2 dt$	$T_{\rm C}$ =25°C, $t_{\rm P}$ =10 ms	5.1	- A ² s
i t value	J' at	$T_{\rm C} = 150^{\circ} {\rm C}$, $t_{\rm P} = 10 {\rm ms}$		7 45
Operating junction and storage temperature range	$T_{\rm vj}$, $T_{\rm stg}$		-55+175	°C

Static Characteristics (tested on wafer), T_{vj} = 25 °C

Parameter	Symbol	Conditions	Value			Unit
raiailletei		Conditions	min.	Тур.	max.	Offic
Reverse current	I_{R}	V _R =600V		0.5	50	μA
Diode forward voltage	V _F	I _F =4A		1.7	1.9	V

Static Characteristics (not subject to production test - verified by design / characterization)

Parameter	Symbol	Conditions	Value			l loit
raidillelei	Symbol	Conditions	min.	Тур.	max.	Unit
Reverse current	I_{R}	$V_{R} = 600 \text{V}, T_{vj} = 150 ^{\circ}\text{C}$		2	500	μA
Diode forward voltage	V _F	I _F =4A, T _{vj} =150°C		2	2.4	V



Dynamic Characteristics (not subject to production test - verified by design / characterization)

Parameter	Symbol	Conditi	Conditions		Value		
- rai ailletei	Symbol	Conditi			Тур.	max.	Unit
Total capacitive charge ³⁾	Q _C	$I_F <= I_{F,max}$	T _{vj} =150°C		8		nC
Switching time ²⁾	tc	di/dt=200A/μs V _R =400V	T _{vj} =150°C			<10	ns
			V _R =1 V		130		
Total capacitance	С	f=1MHz	V _R =300V		20		pF
			V _R =600V		20		

Further Electrical Characteristics

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

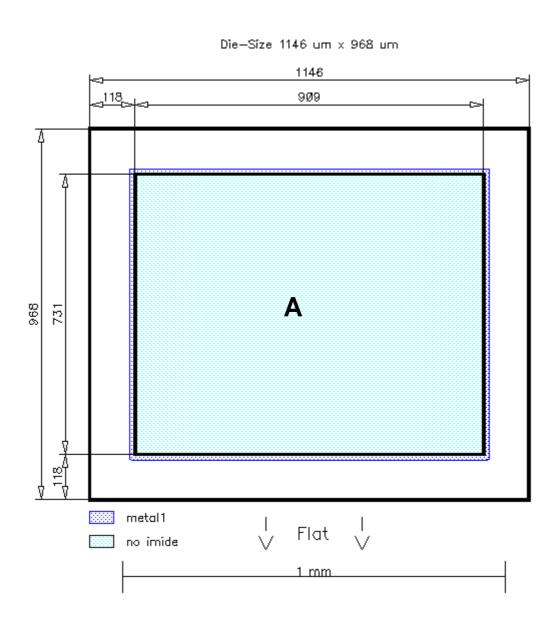
This chip data sheet refers to the device data sheet	IDT04S60C	Rev. 2.1
·		

 $^{^{1)}}$ J-STD20 and JESD22 $^{2)}$ $t_{\rm c}$ is the time constant for the capacitive displacement current waveform (independent from $T_{\rm vj}{=}150\,^{\circ}{\rm C}$, $I_{\rm LOAD}$ and dl/dt), different from $t_{\rm rr}$, which is dependent on $T_{\rm vj}$ =150°C, $I_{\rm LOAD}$, dl/dt. No reverse recovery time constant $t_{\rm rr}$ due to absence of minority carrier inject. $^{3)}$ Only capacitive charge occurring, guaranteed by design (independent from $T_{\rm vj}$, $I_{\rm LOAD}$ and dl/dt).





Chip Drawing



A: Anode pad



Description
AQL 0,65 for visual inspection according to failure catalogue
Electrostatic Discharge Sensitive Device according to MIL-STD 883
Revision History

Version	Subjects (major changes since last revision)	Date

Published by Infineon Technologies AG 81726 Munich, Germany © 2012 Infineon Technologies AG All Rights Reserved.

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

Information

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

Edited by INFINEON Technologies, IFAG IPC TD VLS, L4704E, Edition 1.2, 05.09.2012

单击下面可查看定价,库存,交付和生命周期等信息

>>Infineon(英飞凌)